

<b>Notice of References Cited</b>	Application/Control No. 10/718,815		Applicant(s)/Patent Under Reexamination SEO ET AL.	
	Examiner TUAN H. LE		Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0120681	08-2002	Cho et al.	709/203
*	B	US-5,550,593	08-1996	Nakabayashi, Jiro	348/465
*	C	US-5,594,736	01-1997	Tatsumi et al.	370/474
*	D	US-5,987,214	11-1999	Iwamura, Ryuichi	386/95
*	E	US-2002/0003577	01-2002	Kitsugi et al.	348/232
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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